MOSFET – Power, Dual N-Channel, SOIC-8 40 V, 5.8 A

Features

- Designed for use in low voltage, high speed switching applications
- Ultra Low On–Resistance Provides Higher Efficiency and Extends Battery Life
 - $-R_{DS(on)} = 0.027 \Omega$, $V_{GS} = 10 V (Typ)$
 - $-R_{DS(on)} = 0.034 \Omega$, $V_{GS} = 4.5 V (Typ)$
- Miniature SOIC-8 Surface Mount Package Saves Board Space
- Diode is Characterized for Use in Bridge Circuits
- Diode Exhibits High Speed, with Soft Recovery
- NVMD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable*
- These Devices are Pb-Free and are RoHS Compliant

Applications

- DC-DC Converters
- Computers
- Printers
- Cellular and Cordless Phones
- Disk Drives and Tape Drives

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DSS}	40	V
Gate-to-Source Voltage - Continuous	V_{GS}	±20	V
Drain Current (Note 1) - Continuous @ $T_A = 25^{\circ}C$ - Single Pulse (tp \leq 10 μ s)	I _D	5.8 29	Adc Apk
Drain Current (Note 2) - Continuous @ T _A = 25°C	I _D	4.6	Adc
Total Power Dissipation @ T _A = 25°C (Note 1) @ T _A = 25°C (Note 2)	P _D	2.0 1.29	W
Operating and Storage Temperature Range	T _J , T _{stg}	-55 to +150	°C
Single Pulse Drain-to-Source Avalanche Energy – Starting $T_J = 25^{\circ}\text{C}$ ($V_{DD} = 40 \text{ Vdc}, V_{GS} = 5.0 \text{ Vdc}, Vdc, Peak I_L = 7.0 \text{ Apk}, L = 10 \text{ mH}, R_G = 25 \Omega)$	E _{AS}	245	mJ
Thermal Resistance - Junction-to-Ambient (Note 1) - Junction-to-Ambient (Note 2)	$R_{\theta JA}$	62.5 97	°C/W
Maximum Lead Temperature for Soldering Purposes for 10 Sec	T _L	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. When surface mounted to an FR4 board using 1" pad size, $t \le 10 \text{ s}$

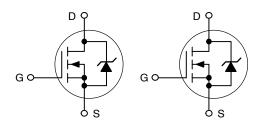


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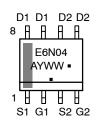
V _{DSS}	R _{DS(ON)} Typ	I _D Max	
40 V	27 mΩ @ V _{GS} = 10 V	5.8 A	

N-Channel



MARKING DIAGRAM & PIN ASSIGNMENT





E6N04 = Specific Device Code A = Assembly Location

Y = Year WW = Work Week • Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMD6N04R2G	SOIC-8 (Pb-Free)	2500 / Tape & Reel
NVMD6N04R2G*	SOIC-8 (Pb-Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

2.	When surface mounted to an FR4 board using 1" pad size, t = steady state

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted)

Characteristic			Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage (V _{GS} = 0 Vdc, I _D = 250 μA) Temperature Coefficient (Positive)			40 -	47 45	- -	Vdc mV/°C
Zero Gate Voltage Drain Current $(V_{DS} = 40 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_J = (V_{DS} = 40 \text{ Vdc}, V_{DS} = 40 \text{ Vdc}, T_J = (V_{DS} = 40 \text{ Vdc}, V_$		I _{DSS}	- -	- -	1.0 10	μAdc
Gate-Body Leakage Current (V _{GS} = ±20 Vdc, V _{DS} = 0 Vdc)		I _{GSS}	-	-	± 100	nAdc
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage (V _{DS} = V _{GS} , I _D = 250 μAdc) Temperature Coefficient (Negative)		$V_{GS(th)} \ V_{GS(th)}/T_J$	1.0	1.9 4.7	3.0	Vdc mV/°C
Static Drain-to-Source On-State Resistance ($V_{GS} = 10 \text{ Vdc}$, $I_D = 5.8 \text{ Adc}$) ($V_{GS} = 4.5 \text{ Vdc}$, $I_D = 3.9 \text{ Adc}$)		R _{DS(on)}	- -	0.027 0.034	0.034 0.043	Ω
Forward Transconductance (V _{DS} = 10 Vdc, I _D = 5.8 Adc)	9FS	_	8.12	-	Mhos	
DYNAMIC CHARACTERISTICS						
Input Capacitance		C _{iss}	-	723	900	pF
Output Capacitance	(V _{DS} = 32 Vdc, V _{GS} = 0 Vdc, f = 1.0 MHz)	C _{oss}	-	156	225	
Reverse Transfer Capacitance		C _{rss}	-	53	75	
SWITCHING CHARACTERISTICS (N	otes 3 & 4)					•
Turn-On Delay Time		t _{d(on)}	-	10	18	ns
Rise Time	$(V_{DD} = 20 \text{ Vdc}, I_D = 5.8 \text{ A}, V_{GS} = 10 \text{ V},$	t _r	-	20	35	
Turn-Off Delay Time	$R_{G} = 10 \text{ V},$ $R_{G} = 6 \Omega)$	t _{d(off)}	-	45	70	
Fall Time		t _f	-	40	65	
Turn-On Delay Time		t _{d(on)}	-	15	-	ns
Rise Time	$(V_{DD} = 20 \text{ Vdc}, I_D = 5.8 \text{ A},$	t _r	-	55	-	
Turn-Off Delay Time	$V_{GS} = 4.5 \text{ V},$ $R_G = 6 \Omega)$	t _{d(off)}	-	30	-	
Fall Time		t _f	-	35	-	
Gate Charge	(V _{DS} = 20 Vdc,	Q _T	-	20	30	nC
	$V_{GS} = 10 \text{ Vdc},$	Q_{gs}	-	2.5	_	
	I _D = 5.8 A)	Q _{gd}	-	5.5	-	
BODY-DRAIN DIODE RATINGS (Not	+	,		.	1	
Diode Forward On-Voltage	$(I_S = 1.7 \text{ Adc}, V_{GS} = 0 \text{ V})$ $(I_S = 1.7 \text{ Adc}, V_{GS} = 0 \text{ V}, T_J = 150^{\circ}\text{C})$	V _{SD}	<u>-</u> -	0.76 0.56	1.1 -	Vdc
Reverse Recovery Time			_	23	_	ns
	$(I_S = 1.7 \text{ A}, V_{GS} = 0 \text{ V}, \\ dI_S/dt = 100 \text{ A/}\mu\text{s})$	ta	-	16	_	
		t _b	-	7	-	
Reverse Recovery Stored Charge (I _S = 1.7 A, dI _S /dt = 100 A/μs, V _{GS} = 0	Q _{RR}	-	20	-	nC	

^{3.} Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%. 4. Switching characteristics are independent of operating junction temperature.

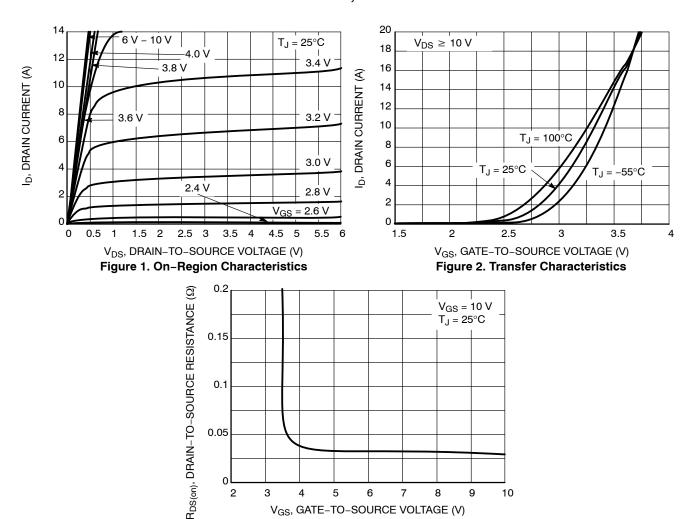


Figure 3. On-Resistance vs. Gate-to-Source Voltage

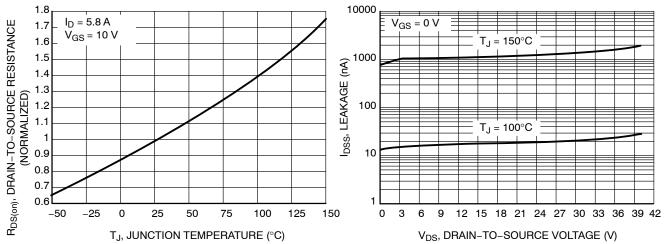


Figure 4. On Resistance Variation with Temperature

Figure 5. Drain-to-Source Leakage Current vs. Voltage

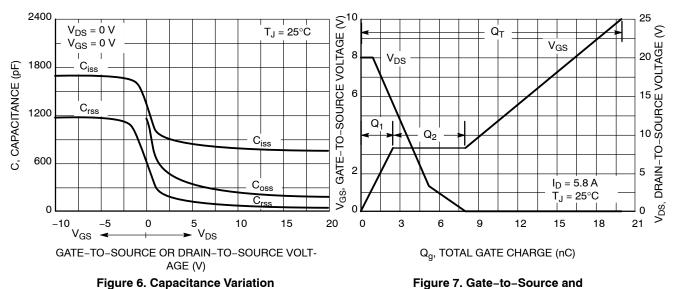


Figure 6. Capacitance Variation

4 100 $V_{GS} = 0 V$ $V_{GS} = 20 \text{ V}$ 3.5 $T_J = 25^{\circ}C$ Single Pulse T_C IS, SOURCE CURRENT (A) T_A = 25°C _D, DRAIN CURRENT (A) 3 10 10 μs 2.5 100 μs 2 1 ms R_{DS(on)}
THERMAL LIMIT 10 ms 1.5 PACKAGE LIMIT 0.1 1 ----dc 0.5 Mounted on FR4 board using 1 in pad size, with die operating 10s max. 0 0.01 0.4 0.6 0.9 0.1 10 100 V_{SD}, SOURCE-TO-DRAIN VOLTAGE (V) V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

Figure 8. Diode Forward Voltage vs. Current

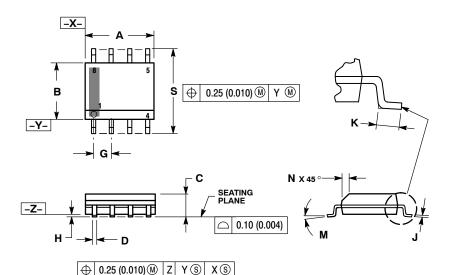
Figure 9. Maximum Rated Forward Biased Safe Operating Area

Drain-to-Source Voltage vs. Total Charge



SOIC-8 NB CASE 751-07 **ISSUE AK**

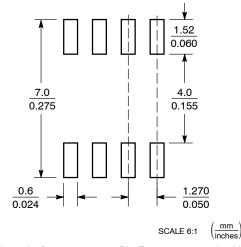
DATE 16 FEB 2011



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

	MILLIMETERS		INCHES		
DIM	MIN MAX		MIN	MAX	
Α	4.80	5.00	0.189	0.197	
В	3.80	3.80 4.00		0.157	
C	1.35	1.75	0.053	0.069	
D	0.33 0.51		0.013	0.020	
G	1.27 BSC		0.050 BSC		
Н	0.10	0.10 0.25		0.010	
J	0.19	0.25	0.007	0.010	
K	0.40 1.27		0.016	0.050	
M	0 ° 8 °		0 °	8 °	
N	0.25	0.50	0.010	0.020	
S	5.80	6.20	0.228	0.244	

SOLDERING FOOTPRINT*



^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location = Wafer Lot

= Year = Work Week = Pb-Free Package XXXXXX AYWW AYWW Ŧ \mathbb{H} Discrete **Discrete** (Pb-Free)

XXXXXX = Specific Device Code = Assembly Location Α

= Year ww = Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

STYLES ON PAGE 2

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SOIC-8 NB CASE 751-07 ISSUE AK

DATE 16 FEB 2011

			27112 101 22 2
STYLE 1: PIN 1. EMITTER 2. COLLECTOR 3. COLLECTOR 4. EMITTER 5. EMITTER 6. BASE 7. BASE 8. EMITTER	STYLE 2: PIN 1. COLLECTOR, DIE, #1 2. COLLECTOR, #1 3. COLLECTOR, #2 4. COLLECTOR, #2 5. BASE, #2 6. EMITTER, #2 7. BASE, #1 8. EMITTER, #1	STYLE 3: PIN 1. DRAIN, DIE #1 2. DRAIN, #1 3. DRAIN, #2 4. DRAIN, #2 5. GATE, #2 6. SOURCE, #2 7. GATE, #1 8. SOURCE, #1	
STYLE 5: PIN 1. DRAIN 2. DRAIN 3. DRAIN 4. DRAIN 5. GATE 6. GATE 7. SOURCE 8. SOURCE	STYLE 6: PIN 1. SOURCE 2. DRAIN 3. DRAIN 4. SOURCE 5. SOURCE 6. GATE 7. GATE 8. SOURCE	STYLE 7: PIN 1. INPUT 2. EXTERNAL BYPASS 3. THIRD STAGE SOURCE 4. GROUND 5. DRAIN 6. GATE 3 7. SECOND STAGE Vd 8. FIRST STAGE Vd	STYLE 8: PIN 1. COLLECTOR, DIE #1 2. BASE, #1 3. BASE, #2 4. COLLECTOR, #2 5. COLLECTOR, #2 6. EMITTER, #2 7. EMITTER, #1 8. COLLECTOR, #1
STYLE 9: PIN 1. EMITTER, COMMON 2. COLLECTOR, DIE #1 3. COLLECTOR, DIE #2 4. EMITTER, COMMON 5. EMITTER, COMMON 6. BASE, DIE #2 7. BASE, DIE #1 8. EMITTER, COMMON	STYLE 10: PIN 1. GROUND 2. BIAS 1 3. OUTPUT 4. GROUND 5. GROUND 6. BIAS 2 7. INPUT 8. GROUND STYLE 14: PIN 1. N-SOURCE 2. N-GATE 3. P-SOURCE	STYLE 11: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 8. DRAIN 1	STYLE 12: PIN 1. SOURCE 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN
STYLE 13: PIN 1. N.C. 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN	STYLE 14: PIN 1. N-SOURCE 2. N-GATE 3. P-SOURCE 4. P-GATE 5. P-DRAIN 6. P-DRAIN 7. N-DRAIN 8. N-DRAIN	8. DHAIN 1 STYLE 15: PIN 1. ANODE 1 2. ANODE 1 3. ANODE 1 4. ANODE 1 5. CATHODE, COMMON 6. CATHODE, COMMON 7. CATHODE, COMMON 8. CATHODE, COMMON	STYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #2 4. BASE, DIE #2 5. COLLECTOR, DIE #2 6. COLLECTOR, DIE #2 7. COLLECTOR, DIE #1 8. COLLECTOR, DIE #1
STYLE 17: PIN 1. VCC 2. V2OUT 3. V1OUT 4. TXE 5. RXE 6. VEE 7. GND 8. ACC	STYLE 18: PIN 1. ANODE 2. ANODE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. CATHODE 8. CATHODE	STYLE 19: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. MIRROR 2 7. DRAIN 1 8. MIRROR 1	STYLE 20: PIN 1. SOURCE (N) 2. GATE (N) 3. SOURCE (P) 4. GATE (P) 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN
6. VEE 7. GND 8. ACC STYLE 21: PIN 1. CATHODE 1 2. CATHODE 2 3. CATHODE 3 4. CATHODE 4 5. CATHODE 5 6. COMMON ANODE 7. COMMON ANODE 8. CATHODE 6	STYLE 22: PIN 1. I/O LINE 1 2. COMMON CATHODE/VCC 3. COMMON CATHODE/VCC 4. I/O LINE 3 5. COMMON ANODE/GND 6. I/O LINE 4 7. I/O LINE 5 8. COMMON ANODE/GND	STYLE 23: PIN 1. LINE 1 IN 2. COMMON ANODE/GND 3. COMMON ANODE/GND 4. LINE 2 IN 5. LINE 2 OUT 6. COMMON ANODE/GND 7. COMMON ANODE/GND 8. LINE 1 OUT	a COLLECTOR/ANODE
STYLE 25: PIN 1. VIN 2. N/C 3. REXT 4. GND 5. IOUT 6. IOUT 7. IOUT 8. IOUT	STYLE 26: PIN 1. GND 2. dv/dt 3. ENABLE 4. ILIMIT 5. SOURCE 6. SOURCE 7. SOURCE 8. VCC	STYLE 27: PIN 1. ILIMIT 2. OVLO 3. UVLO 4. INPUT+ 5. SOURCE 6. SOURCE 7. SOURCE 8. DRAIN	STYLE 28: PIN 1. SW_TO_GND 2. DASIC_OFF 3. DASIC_SW_DET 4. GND 5. V_MON 6. VBULK 7. VBULK 8. VIN
STYLE 29: PIN 1. BASE, DIE #1 2. EMITTER, #1 3. BASE, #2 4. EMITTER, #2 5. COLLECTOR, #2 6. COLLECTOR, #2 7. COLLECTOR, #1 8. COLLECTOR, #1	STYLE 30: PIN 1. DRAIN 1 2. DRAIN 1 3. GATE 2 4. SOURCE 2 5. SOURCE 1/DRAIN 2 6. SOURCE 1/DRAIN 2 7. SOURCE 1/DRAIN 2 8. GATE 1		

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